## NB3N3020DTGEVB

## NB3N3020DTGEVB Evaluation Board User's Manual

## Device Name: NB3N3020DTG (TSSOP-16) Board Name: NB3N3020DTGEVB

## Description

The NB3N3020DTG is a high precision, low phase noise selectable clock multiplier. The device takes a $5-27 \mathrm{MHz}$ fundamental mode parallel resonant crystal or a 2 210 MHz LVCMOS single ended clock source and generates a differential LVPECL output and a single ended LVCMOS/LVTTL output at a selectable clock output frequency which is a multiple of the input clock frequency. Three tri - level (Low, Mid, High) LVCMOS/LVTTL single ended select pins set one of 26 possible clock multipliers. An LVCMOS/LVTTL output enable (OE) tri-states clock outputs when low. This device is housed in $5 \mathrm{~mm} \times 4.4 \mathrm{~mm}$ narrow body TSSOP-16 pin package.

See datasheet NB3N3020/D (www.onsemi.com).The NB3N3020DTGEVB Evaluation board is designed to provide a flexible and convenient platform to quickly program, evaluate and verify the performance and operation of the NB3N3020DTG TSSOP - 16 device under test:


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## Board Features

- Crystal source or external input clock source (SMA). One 25 MHz crystal is supplied.
- A TSSOP-16 NB3N3020DTG device is installed.
- Separate supply connectors for VDD, GND, and VEE (GND $=$ SMAGND $=0 \mathrm{~V}$ ) (banana jacks and Anvil Clips)


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Figure 1. NB3N3020DTGEVB Evaluation Board

## NB3N3020DTGEVB

BOARD LAYOUT


Figure 2. FRONT Board Layout


Figure 3. FRONT Layer Design

## NB3N3020DTGEVB



Figure 4. BACK Board Layout


Figure 5. BACK Layer Design

## TEST AND MEASUREMENT SET-UP AND PROCEDURE

## Step 1: Equipment

1. Signal Generator: Agilent \#33250A or HP8133 (or equivalent)
2. Tektronix TDS8000 Oscilloscope
3. Power Supply: Agilent \#6624A or AG6626A DC (or equivalent)
4. Digital Voltmeter: Agilent 34410A or 34401 (or equivalent)
5. Matched Cables (> 20 GHz , SMA connectors): Storm or Semflex (or equivalent)
6. Time Transition Convertor: Agilent 14534250 ps (or equivalent)
7. Phase noise Analyzer: Agilent E5052B (or equivalent)

## Step 2: Lab Set-Up Procedure

1. Test Supply Setup:

Board and Device Power Supply Connections are shown in Table 1. VDD, VEE, and GND and may be connected by banana jacks or anvil clip test points.

Table 1. POWER SUPPLY CONNECTIONS

| Device | Board | Banana Jack | Anvil Clip <br> Test Point | Comments |
| :---: | :---: | :---: | :---: | :---: |
| VDD | VDD | BJ1 | J 11 | VDD, VDD1, and VDD2 are shorted by R12 |
| VDD | VDD2 | BJ1 | J 18 |  |
| VDD | VDD3 | BJ1 | J 18 |  |
| GND | VEE | BJ2 | J 7 | DUTGND |
|  | SMAGND | BJ3 | J 19 | Shield GND = 0 V |

SINGLE SUPPLY OPERATION (VD $=3.3 \mathrm{~V}$; GND $=0.0 \mathrm{~V}$; $\mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}$ )

Single supply operation may be accomplished by shunting GND (SMAGND) and VEE (DUTGND). Input and output levels are not shifted, but High Impedance Probes
must be used to sense the outputs. LVPECL outputs CLK2 and CLK2b must be terminated with $50 \Omega$ into a VTT type current sinking supply of $\mathrm{V}_{\mathrm{DD}}-2.0 \mathrm{~V}$ per Figure 6. High Impedance probes must be used to sense the signal levels.


Figure 6. Typical Device Termination Setup and Termination for Single Ended Operation (High Impedance Scope or Probes)

SPLIT SUPPLY OPERATION (VDD = 2.0 V; GND $=0.0 \mathrm{~V}$; VEE $=-1.3 \mathrm{~V}$ )

For offset or split supply operation, the VDD supply is offset -1.3 V to 2.0 V with respect to GND (SMAGND) and VEE is set to -1.3 V for 3.3 V supply span operation. Supply variance is done by adjusting the VEE supply ( $\pm 5 \%$ ). Split supply operation offers the advantage of connecting the

LVPECL outputs (CLK2 and CLK2b) directly to a $50 \Omega$ input impedance counter or oscilloscope (or use of Low Impedance probes) per Figure 7. All input and output levels will be offset or shifted -1.3 V. The LVCMOS output CLK1 will be properly terminated but also offset or shifted -1.3 V . Low Impedance ( $50 \Omega$ ) probes must be used to sense the signal levels.


Figure 7. Typical Device Termination Setup and Termination for Split Supply Operation ( $50 \Omega$ Low Impedance Scope or Probes)
2. Inputs: (see Appendix 1, Device Pin to Board Connection Information)

## SINGLE SUPPLY OPERATION (VDD = 3.3 V ; GND $=0.0 \mathrm{~V}$; VEE $=0.0 \mathrm{~V}$ )

For a Single Ended input to X1/CLK operation, remove the crystal loading caps C41 and C42 and bridge the small topside trace gap from the device input pin to the SMA connector by installing R14 (a Zero $\Omega$ resistor). Do not install R16. Do not drive X2. Use a LVCMOS Clock amplitude signal from 2 MHz to 210 MHz which satisfies datasheet VIH and VIL to drive X1/CLK. Input tr/tf transition edges should be about 250 ps . Use a TTC (Time transition Convertor) such as Agilent 14534 ( 250 ps) or equivalent, if needed, to slow faster edges. Termination of a signal generator may be accomplished by placing a $50 \Omega$ resistor (to GND) at location C42. The mounted crystal does not need to be removed for Single Ended input operation.

For Crystal operation use a fundamental Parallel Resonant crystal (see Datasheet section on "Recommended Crystal Parameters") from 5 MHz to 27 MHz . The board is supplied with a thru-hole 25 MHz crystal installed, but alternatively has the tabs for a surface mount crystal. The Crystal mount is located on the back (underside) of the board and is permanently connected to the device inputs by traces. Crystal Load capacitors (C41 and C42) of $27 \mu \mathrm{~F}$ are mounted.

Device frequency is selected by three level inputs SEL0, SEL1, SEL2. Jumpers J10 (SEL0), J13 (SEL1), and J14 (SEL2) may be set to either VDD (HI), VEE (LO), or floated open (MID) to program the output frequency of operation per datasheet Table 2. Jumpers may be removed to drive SEL0/1/2 directly with spec VIH, VIL, or VIM levels. Note SEL0/1/2 inputs will default to VDD/2 (MID) when left floating open. High Impedance probes must be used to sense the signal levels.

Inputs OE1 and OE2 may be jumpered to VEE (GND) for a LOW level (DISABLED) using J15 (OE1) or J12 (OE2). If floated open (jumper removed), pin will default to a HIGH level (ENABLED). High Impedance probes must be used to sense the signal levels.

## SPLIT SUPPLY OPERATION (VDD = 2.0 V ; GND $=0.0 \mathrm{~V}$; VEE $=-1.3 \mathrm{~V}$ )

For a Single Ended input to X1/CLK operation, remove the crystal loading caps C41 and C42 and bridge the small topside trace gap from the device input pin to the SMA connector by installing R14 (a Zero $\Omega$ resistor). Do not install R16. Do not drive X2. Use -1.3 V offset LVCMOS Clock amplitude signal from 2 MHz to 210 MHz which satisfies datasheet VIH and VIL to drive X1/CLK. Input tr/tf transition edges should be about 250 ps. Use a TTC (Time Transition Convertor) such as Agilent 14534 ( 250 ps ) or equivalent, if needed to supply proper edges. Termination of a signal generator may be accomplished by placing a $50 \Omega$ resistor (to GND) at location C42. The mounted crystal does not need to be removed for Single Ended input operation.

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3. Outputs: LVPECL outputs (CLK2, CLK2b):

SINGLE SUPPLY OPERATION (VDD = 3.3 V ; GND $=0.0$
V' VEE $=0.0 \mathrm{~V}$ )
Externally connect LVPECL outputs CLK2 and CLK2b through a $50 \Omega$ terminating resistor to a VTT current sinking regulated supply set to VDD-2V per Figure 6. High Impedance probes must be used to sense the signal levels.

Alternatively, use of a VTT current sinking regulated supply may be avoided by populating R6 (82 $\Omega$ ) and R7 (130 $\Omega)$ to terminate CLK2 and populating R2 (82 $\Omega$ ) and R3 $(130 \Omega)$ to terminate CLK2b as per Figure 8 Alternative Device Termination Setup for On-Board Termination. High Impedance probes must be used to sense the signal levels.


Figure 8. Alternative Device Termination Setup for On-Board Termination

SPLIT SUPPLY OPERATION (VDD = 2.0 V ; GND = 0.0 V ; VEE $=-1.3 \mathrm{~V}$ )

Externally connect LVPECL outputs CLK2 and CLK2b directly to a counter or scope (with $50 \Omega$ input impedance) or use Low Impedance Probes ( $50 \Omega$ ) per Figure 7. NOTE: THE READINGS OF THE OUTPUT VOLTAGE LEVELS WILL BE OFFSET -1.3 V.

Alternatively, LVPECL outputs CLK2 and CLK2b may be terminated on the board by populating R6 ( $82 \Omega$ ) and R7 $(130 \Omega)$ to terminate CLK2 and populating R2 $82 \Omega$ ) and R3 (130 $\Omega$ ) to terminate CLK2b as per Figure 6. High Impedance probes must be used to sense the signal levels. NOTE: THE READINGS OF THE OUTPUT VOLTAGE LEVELS WILL BE OFFSET - 1.3 V.

## APPENDIX 1: DEVICE PIN TO BOARD CONNECTION INFORMATION (SEE CURRENT DATASHEET)

Table 2. DEVICE PINS TO BOARD CONNECTION

| Device Pin | Device Pin Name | Board Connection | 1/0 | Description |
| :---: | :---: | :---: | :---: | :---: |
| 1 | VDD | VDD | Positive Supply | Positive Supply pin. All Supply pins must be connected for proper operation |
| 2 | X1/CLK | X1/CLK | Crystal Interface | Oscillator Input from Crystal. Single ended Clock Input. |
| 3 | X2 | X2 | Crystal Interface | Oscillator Output to drive Crystal |
| 4 | SEL2 | SEL2 | Tri - Level Input | Frequency select input 2. |
| 5 | SEL1 | SEL1 | Tri - Level Input | Frequency select input 1 |
| 6 | SELO | SELO | Tri - Level Input | Frequency select input 0 |
| 7 | OE1 | OE1 | LVCMOS Input | Input pin OE1 accepts LVCMOS levels to control CLK1 (tristates CLK1 when LOW, open pin defaults to HIGH ) |
| 8/ | GND | VEE | Negative Supply | DUT GND. All Supply pins must be connected for proper operation |
| 9 | GND | VEE | Negative Supply | DUT GND. All Supply pins must be connected for proper operation |
| 10 | CLK1 | CLK1 | LVCMOS Output | LVCMOS Output |
| 11 | VDD | VDD2, | POWER | Positive Supply pin. All Supply pins must be connected for proper operation |
| 12 | GND | VEE | Negative Supply | DUT GND |
| 13 | CLK2 | CLK2 | LVPECL Output | True LVPECL Output |
| 14 | CLK2b | CLK2b | LVPECL Output | Invert LVPECL Output |
| 15 | VDD | VDD3 | POWER | Positive Supply pins. All Supply pins must be connected for proper operation |
| 16 | OE2 | OE2 | LVCMOS Input | Input pin OE2 accepts LVCMOS levels to control LVPECL Output CLK2 and CLK2b (when LOW forces CLK1 LOW and CLK2b HIGH, open pin defaults to HIGH ) |



Figure 9. Schematic

## APPENDIX 3: BILL OF MATERIALS, LAMINATION STACKUP, AND ASSEMBLY NOTES

Table 3. BILL OF MATERIAL

| Item | Qty | Schematic | Value | Size | MFG | P/N | Description |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| 1 | 3 | BJ1-BJ3 |  |  | ITT POMONA ELECTRONICS | B-JACK 1/4-32 THREAD | BANANAJACK |
| 2 | 8 | $\begin{gathered} \mathrm{C} 2, \mathrm{C} 3, \mathrm{C}, \mathrm{C} 8, \mathrm{C} 14, \mathrm{C} \\ 16, \mathrm{C} 18, \mathrm{C} 21 \end{gathered}$ | .01ufd | 0402 | AVX Corporation | 04023C103KAT2A | CAP CERM .01UF 10\% 25V X7R |
| 3 | 9 | C1,C4,C6,C11,C15, C17,C19,C20,C22 | .01ufd | 0603 | Murata | GRM188R71H103KA01D | CAP CER 10000PF 50V 10\% X7R |
| 4 | 2 | C7, C10 | .01ufd | 0805 | TDK | C2012X7R1H103K | CAP CER .01UF 50V X7R 10\% |
| 5 | 2 | C41,C42 | 27pfd | 0603 | AVX Corporation | 06031A270FAT2A | CAP CERM 27PF 1\% 100V NP0 |
| 6 | 3 | C9,C12,C13 | 10ufd | 7343 | Kemet | T491C106K016AT | CAPACITOR TANT 10UF 16V 10\% SMD |
| 7 | 2 | J12,J15 | 2 Pin |  | Sullins | PEC36SACN | CONN HEADER . 100 SINGL STR 36POS |
| 8 | 5 | J10,J12,J13, J14,J15 |  |  | SULLINS ELECTRONICS CORP | STC02SYAN | CONN JUMPER SHORTING TIN |
| 9 | 3 | J10,J13,J14 | 3 Pin |  | Sullins | PEC36SACN | CONN HEADER . 100 SINGL STR 36POS |
| 10 | 1 | R1 | 33.2 | 0805 | Panasonic - ECG | ERJ-2RKF33R2X | RES $33.2 \Omega$ 1/16W 1\% 0805 SMD |
| 11 | 1 | R12 | 0 | 0805 |  |  |  |
| 12 | 10 | $\begin{gathered} \hline \mathrm{J} 1, \mathrm{~J} 2, \mathrm{~J} 3, \mathrm{~J} 4, \mathrm{~J} 5, \mathrm{~J} 6, \mathrm{~J} 8 \\ \text {, } 9, \mathrm{~J} 16, \mathrm{~J} 17 \end{gathered}$ |  |  | Emerson Network Power Connectivity Solutions | 142-0701-801 | Johnson SMA Connector - Side Launch |
| 13 | 4 | J7,J11,J18, J19 | SMT |  | KEYSTONE ELECTRONICS | 5016 | PC TEST POINT "ANVIL" COMPACT SMT |
| 14 | 2 | Y1 Crystal Socket Receptacle | BOTTOM |  | Ampere | 2-330808-8 | RECEPTACLE FOR LEADED CRYSTAL 0.013-0.21 30AU |
| 15 | 4 | Standoff |  |  |  |  | Nylon Standoff |
| 16 | 4 | Screw |  |  |  |  | Nylon Screw |
| 17 | 1 | C2 |  | 0402 |  |  | NOT INSTALLED |
| 18 | 9 | R2,R3,R4,R5,R6,R7 ,R8,R11,R15 |  | 0805 |  |  | NOT INSTALLED |
| 19 | 2 | R14,R16 |  | 0603 |  |  | NOT INSTALLED |
| 20 | 1 | Y1 | 25 MHz |  | Abracon | ABL-25.000MHZ-B2F | Through Hole Crystal |
| 22 | 1 | U1 |  |  | On Semi | NB3N3020DTG | 16 lead TSSOP DUT |



Figure 10. Lamination Stack
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